Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/706,050	LEE ET AL.	
Examiner	Art Unit	
HOAN C. NGUYEN	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	update	6/14/2006	CHN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search in US-PGPUB, USPAT, EPO, JPO, Derwent and IBM_TDB	6/14/2006	CHN	